

**INDUSTRY STANDARD OF THE
PEOPLE'S REPUBLIC OF CHINA**

YD/T 3037.1-2023

**Test method for characteristics of mass storage interface
between Universal Integrated Circuit Card (UICC) and terminal -
Part 1: Terminal
(English Translation)**

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What this standard covers

This standard specifies the testing method for the characteristics of the large-capacity storage interface between the Universal Integrated Circuit Card (UICC) on the terminal and the terminal, mainly including: electrical characteristics, establishment of initial communication protocol, performance testing and functional testing. This standard applies to the development and production of terminal interfaces that support large-capacity storage interfaces.

Document data

Chinese classification (CCS): M36.